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February 2014

FDMA908PZ

Single P-Channel PowerTrench® MOSFET

-12 V, -12 A, 12.5 m Ω

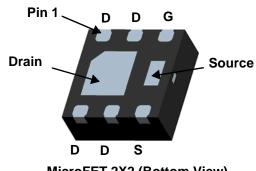
Features

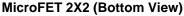
- Max $r_{DS(on)}$ = 12.5 m Ω at V_{GS} = -4.5 V, I_D = -12 A
- Max $r_{DS(on)}$ = 18 m Ω at V_{GS} = -2.5 V, I_D = -10 A
- \blacksquare Max $r_{DS(on)}$ = 28 m Ω at V_{GS} = -1.8 V, I_D = -8 A
- Low Profile 0.8 mm maximum in the new package MicroFET 2x2 mm
- HBM ESD protection level > 2.8 kV typical (Note 3)
- Free from halogenated compounds and antimony oxides
- RoHS Compliant

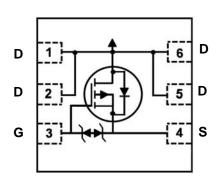


General Description

This device is designed specifically for battery charge or load switching in cellular handset and other ultraportable applications. It features a MOSFET with low on-state resistance and zener diode protection against ESD. The MicroFET 2X2 package offers exceptional thermal performance for its physical size and is well suited to linear mode applications.







MOSFET Maximum Ratings T_A = 25 °C unless otherwise noted

Symbol	Param		Ratings	Units	
V _{DS}	Drain to Source Voltage		-12	V	
V _{GS}	Gate to Source Voltage			±8	V
I _D	Drain Curre -Continuous	T _A = 25 °C	(Note 1a)	-12	٨
	-Pulsed			-40	A
D	Power Dissipation	T _A = 25 °C	(Note 1a)	2.4	W
P_{D}	Power Dissipation	T _A = 25 °C	(Note 1b)	0.9	VV
T _J , T _{STG}	Operating and Storage Junction Temperature Range			-55 to +150	°C

Thermal Characteristics

$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	(Note 1a)	52	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	(Note 1b)	145	C/VV

Package Marking and Ordering Information

Device Marking	Device	Package	Reel Size	Tape Width	Quantity
908	FDMA908PZ	MicroFET 2X2	7 "	12 mm	3000 units

Electrical Characteristics $T_J = 25$ °C unless otherwise noted

Symbol	Parameter	Test Conditions	Min	Тур	Max	Units
Off Chara	acteristics					
BV _{DSS}	Drain to Source Breakdown Voltage	$I_D = -250 \mu A, V_{GS} = 0 V$	-12			V
$\frac{\Delta BV_{DSS}}{\Delta T_{J}}$	Breakdown Voltage Temperature Coefficient	I_D = -250 μ A, referenced to 25 °C		-10		mV/°C
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} = -9.6 V, V _{GS} = 0 V			-1	μΑ
I _{GSS}	Gate to Source Leakage Current	$V_{GS} = \pm 8 \text{ V}, V_{DS} = 0 \text{ V}$			±10	μА

On Characteristics

$V_{GS(th)}$	Gate to Source Threshold Voltage	$V_{GS} = V_{DS}, I_D = -250 \mu A$	-0.4	-0.6	-1	V
$\frac{\Delta V_{GS(th)}}{\Delta T_J}$	Gate to Source Threshold Voltage Temperature Coefficient	I_D = -250 μ A, referenced to 25 °C		2.8		mV/°C
		$V_{GS} = -4.5 \text{ V}, I_D = -12 \text{ A}$		10	12.5	
		$V_{GS} = -2.5 \text{ V}, I_D = -10 \text{ A}$		13	18	
r _{DS(on)}	Static Drain to Source On Resistance	$V_{GS} = -1.8 \text{ V}, I_D = -8 \text{ A}$		18	28	mΩ
		$V_{GS} = -4.5 \text{ V}, I_D = -12 \text{ A},$ $T_J = 125 ^{\circ}\text{C}$		13	16	
9 _{FS}	Forward Transconductance	$V_{DD} = -5 \text{ V}, I_{D} = -12 \text{ A}$		63		S

Dynamic Characteristics

C _{iss}	Input Capacitance	V CV V OV	2638	3957	pF
C _{oss}	Output Capacitance	$V_{DS} = -6 \text{ V}, V_{GS} = 0 \text{ V},$ $f = 1 \text{ MHz}$	649	974	pF
C _{rss}	Reverse Transfer Capacitance	1 - 1 1/11/12	602	903	pF

Switching Characteristics

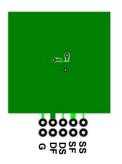
t _{d(on)}	Turn-On Delay Time		11	21	ns
t _r	Rise Time	$V_{DD} = -6 \text{ V}, I_{D} = -12 \text{ A},$ $V_{GS} = -4.5 \text{ V}, R_{GEN} = 6 \Omega$	12	23	ns
t _{d(off)}	Turn-Off Delay Time	$V_{GS} = -4.5 \text{ V}, R_{GEN} = 6.12$	131	223	ns
t _f	Fall Time		71	121	ns
Q_g	Total Gate Charge	$V_{GS} = -4.5 \text{ V}, V_{DD} = -6 \text{ V},$	24	34	nC
Q_{gs}	Gate to Source Charge	I _D = -12 A	3.4		nC
Q _{gd}	Gate to Drain "Miller" Charge		5.3		nC

Drain-Source Diode Characteristics

V _{SD} Source to Drain Diode Forward Voltage	Source to Drain Diode Forward Voltage	$V_{GS} = 0 \text{ V}, I_{S} = -2 \text{ A}$ (Note 2)	-0.6	-1.2	V
	$V_{GS} = 0 \text{ V}, I_{S} = -12 \text{ A}$ (Note 2)	-0.8	-1.2	V	
t _{rr}	Reverse Recovery Time		26	42	ns
Q _{rr}	Reverse Recovery Charge	$T_F = -12 \text{ A}$, $dt/dt = 100 \text{ A/}\mu\text{S}$	8.5	17	nC

NOTES

2



 a. 52 °C/W when mounted on a 1 in² pad of 2 oz copper.



 b. 145 °C/W when mounted on a minimum pad of 2 oz copper.

- 2. Pulse Test: Pulse Width < 300 $\mu\text{s},$ Duty cycle < 2.0%.
- 3. The diode connected between the gate and source serves only as protection against ESD. No gate overvoltage rating is implied.

^{1.} R_{0JA} is determined with the device mounted on a 1 in² pad 2 oz copper pad on a 1.5 x 1.5 in. board of FR-4 material. R_{0JC} is guaranteed by design while R_{0CA} is determined by the user's board design.

Typical Characteristics T_J = 25 °C unless otherwise noted

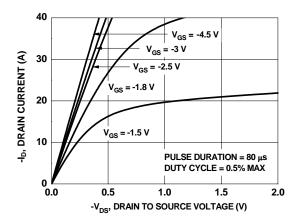


Figure 1. On-Region Characteristics

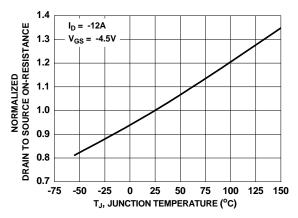


Figure 3. Normalized On-Resistance vs Junction Temperature

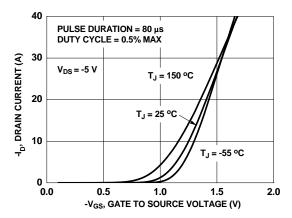


Figure 5. Transfer Characteristics

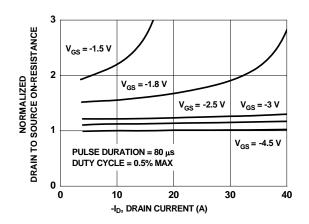


Figure 2. Normalized On-Resistance vs Drain Current and Gate Voltage

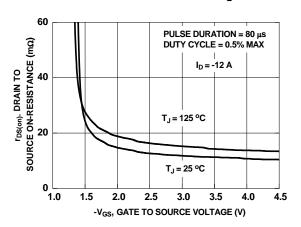


Figure 4. On-Resistance vs Gate to Source Voltage

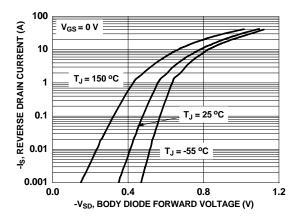


Figure 6. Source to Drain Diode Forward Voltage vs Source Current

Typical Characteristics $T_J = 25$ °C unless otherwise noted

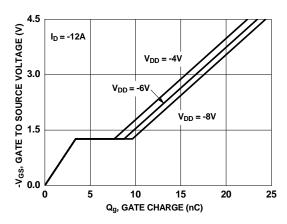


Figure 7. Gate Charge Characteristics

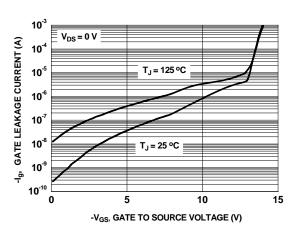


Figure 9. Gate Leakage Current vs Gate to Source Voltage

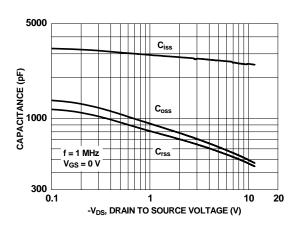


Figure 8. Capacitance vs Drain to Source Voltage

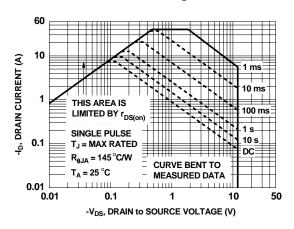


Figure 10. Gate Leakage Current vs Gate to Source Voltage

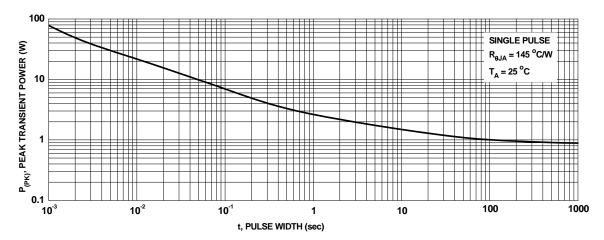


Figure 11. Single Pulse Maximum Power Dissipation

Typical Characteristics T_J = 25 °C unless otherwise noted

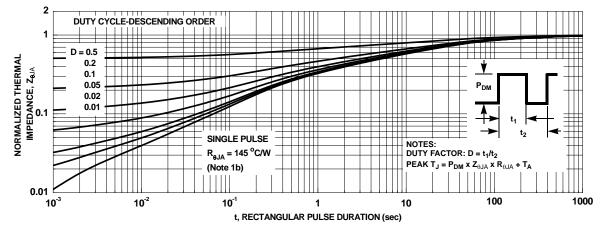
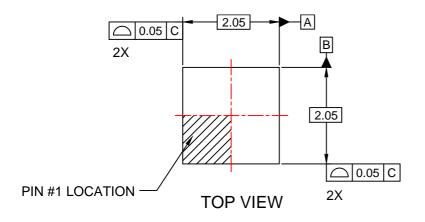
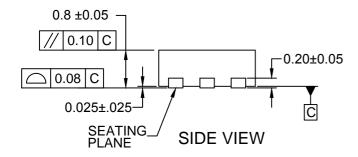
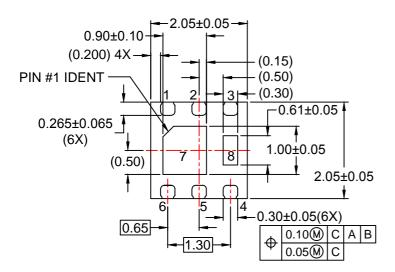


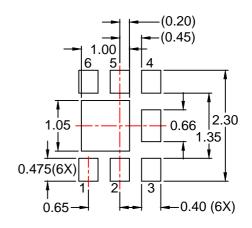
Figure 12. Junction-to-Ambient Transient Thermal Response Curve







BOTTOM VIEW



RECOMMENDED LAND PATTERN

Pin#	Function
1	Drain
2	Drain
3	Gate
4	Source
5	Drain
6	Drain
7	Drain
8	Source

NOTES:

- A. PACKAGE DOES NOT CONFORM TO ANY JEDEC STANDARD.
- B. DIMENSIONS ARE IN MILLIMETERS.
- C. DIMENSIONS AND TOLERANCES PER ASME Y14.5M, 2009.
- D. LAND PATTERN RECOMMENDATION IS EXISTING INDUSTRY LAND PATTERN.
- E. DRAWING FILENAME: MKT-FDMA908Prev1.
- F. REFERENCE DRAWING NO : MKT-MLP06Prev1.



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